

# **AOW284**

# 80V N-Channel AlphaMOS

### **General Description**

• Trench Power AlphaMOS (αMOS MV) technology

• Low R<sub>DS(ON)</sub>

Low Gate Charge

Optimized for fast-switching applications

### **Product Summary**

 $\begin{array}{ll} V_{DS} & 80V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 105A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 4.3 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 6V) & < 5.5 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested



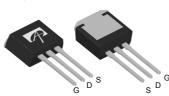
### **Applications**

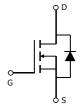
Synchronus Rectification in DC/DC and AC/DC Converters

Industrial and Motor Drive applications

#### TO-262

Top View Bottom View





Orderable Part Number	Package Type	Form	Minimum Order Quantity			
AOW284	TO-262	Tube	1000			
Absolute Maximum Ratings T.=25°C unless otherwise noted						

Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V <sub>DS</sub>	80	V		
Gate-Source Voltage		$V_{GS}$	±20	V		
Continuous Drain	T <sub>C</sub> =25°C		105			
Current G	T <sub>C</sub> =100°C	I <sub>D</sub>	82	Α		
Pulsed Drain Current <sup>c</sup>		I <sub>DM</sub>	400			
Continuous Drain Current	T <sub>A</sub> =25°C		15	۸		
	T <sub>A</sub> =70°C	I <sub>DSM</sub>	12	A		
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	65	Α		
Avalanche energy	L=0.1mH <sup>C</sup>	E <sub>AS</sub>	211	mJ		
V <sub>DS</sub> Spike	10µs	V <sub>SPIKE</sub>	96	V		
	T <sub>C</sub> =25°C	D	250	W		
Power Dissipation B	T <sub>C</sub> =100°C	$-P_D$	125	VV		
	T <sub>A</sub> =25°C	В	1.9	W		
Power Dissipation A	T <sub>A</sub> =70°C	P <sub>DSM</sub>	1.2	VV		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C		

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	R <sub>eJA</sub>	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	I N <sub>θ</sub> JA	55	65	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.52	0.6	°C/W	



### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		80			V
I <sub>DSS</sub> Zero Gate V	Zoro Cato Voltago Drain Current	$V_{DS}$ =80V, $V_{GS}$ =0V				1	μA
	Zero Gate Voltage Drain Current		T <sub>J</sub> =55°C			5	
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		2.3	2.8	3.3	V
		V <sub>GS</sub> =10V, I <sub>D</sub> =20A			3.4	4.3	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T <sub>J</sub> =125°C		5.5	7.0	11177
		$V_{GS}$ =6V, $I_D$ =20A			4.2	5.5	mΩ
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			80		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.69	1	V
Is	Maximum Body-Diode Continuous Current <sup>G</sup>					105	Α
DYNAMIC	CPARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =40V, f=1MHz			5154		pF
Coss	Output Capacitance				673		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				48		pF
$R_g$	Gate resistance	f=1MHz		0.4	0.8	1.2	Ω
SWITCH	NG PARAMETERS	•	•		•	•	='
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =40V, I <sub>D</sub> =20A			71	100	nC
$Q_{gs}$	Gate Source Charge				18.5		nC
$Q_{gd}$	Gate Drain Charge				11.5		nC
$t_{D(on)}$	Turn-On DelayTime				18		ns
$t_r$	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =40V, $R_L$ =2 $\Omega$ , $R_{GEN}$ =3 $\Omega$			11		ns
$t_{D(off)}$	Turn-Off DelayTime				38		ns
t <sub>f</sub>	Turn-Off Fall Time				9		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs			38		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	l <sub>F</sub> =20A, dI/dt=500A/μs			230		nC

A. The value of  $R_{\theta,M}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on R  $_{BJA}$  t 10s and the maximum allowed junction temperature of 150 $^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=775^\circ$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =175° C. D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

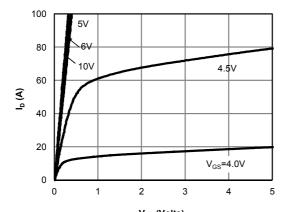
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175 $^{\circ}$  C. The SOA curve provides a single pulse rating.

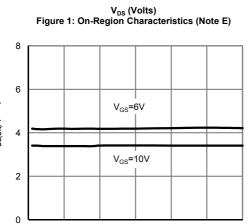
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25° C.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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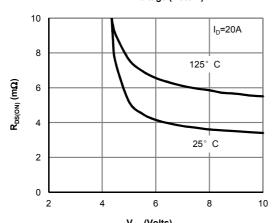
 $\rm I_D$  (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

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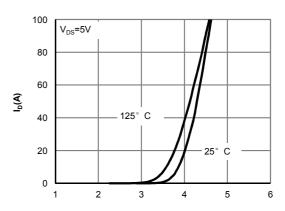
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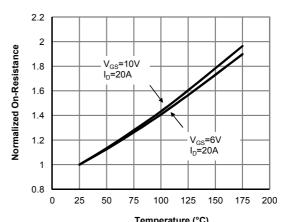
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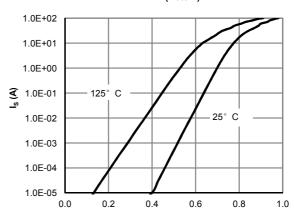
V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>GS</sub>(Volts) Figure 2: Transfer Characteristics (Note E)



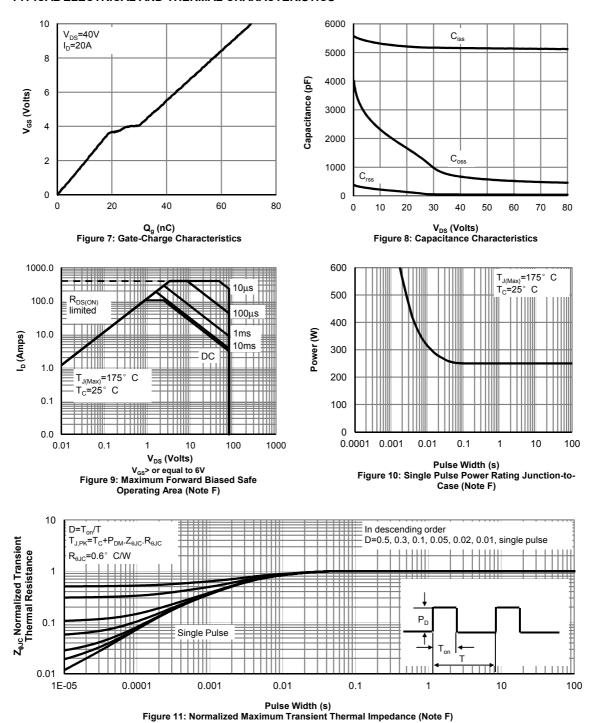
Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



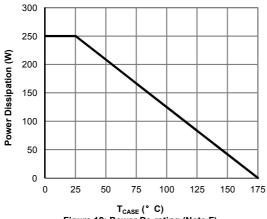
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

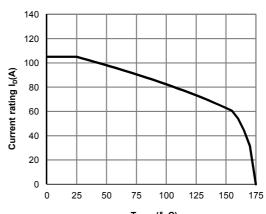


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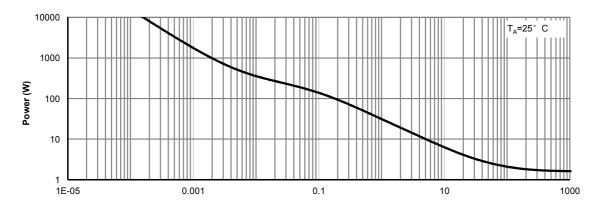
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



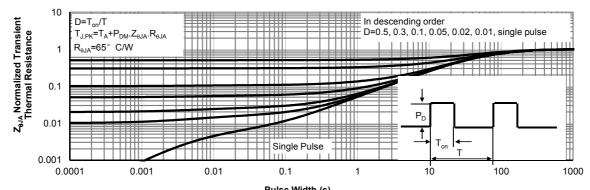


 $T_{\text{CASE}}$  (° C) Figure 12: Power De-rating (Note F)

T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)



Pulse Width (s) Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

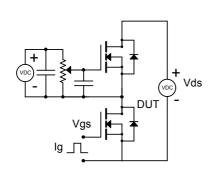


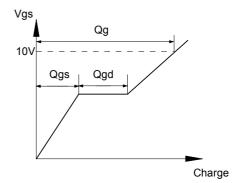
Pulse Width (s)
Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

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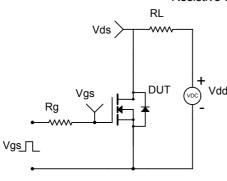


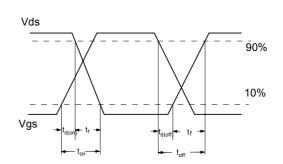
# Gate Charge Test Circuit & Waveform



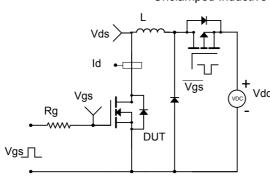


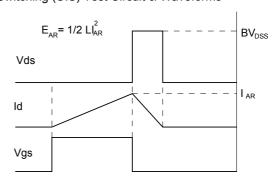
Resistive Switching Test Circuit & Waveforms



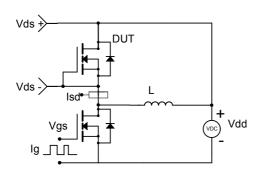


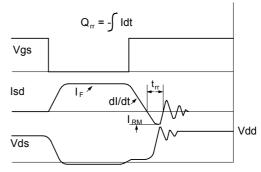
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





### Diode Recovery Test Circuit & Waveforms





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